

# ST3422AS23RG-VB Datasheet

# N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
60	0.030 at V <sub>GS</sub> = 10 V	5.5	2.3 nC			
	$0.033$ at $V_{GS} = 4.5 \text{ V}$	4.5	2.3110			

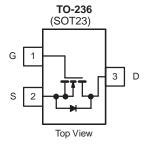
#### **FEATURES**

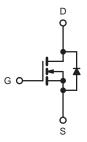
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

# ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- · Battery Switch
- DC/DC Converter





N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	60	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		5.5	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	L .	4.5	
Continuous Diam Current (1) = 130 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	3.9 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>	٦ ,
Pulsed Drain Current	I <sub>DM</sub>	20	A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	la .	1.39	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.91 <sup>b, c</sup>	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	6	
Single-Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	1.8	mJ
	T <sub>C</sub> = 25 °C		1.66	
Mayimum Dayyar Dissination	T <sub>C</sub> = 70 °C	В	1.06	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.09 <sup>b, c</sup>	¬
	T <sub>A</sub> = 70 °C		0.7 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	≤ 5 s	$R_{thJA}$	90	115	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	60	75	C/VV		

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 130 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					I		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	60			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			55		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valtana Dunia Councet	1 .	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	8			Α	
	В	$V_{GS} = 10 \text{ V}, I_D = 1.9 \text{ A}$	0.030				
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 1.7 \text{ A}$		0.033		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> = 1.9 A		5		S	
Dynamic <sup>b</sup>				1	L		
Input Capacitance	C <sub>iss</sub>			190			
Output Capacitance	C <sub>oss</sub>			26			
Reverse Transfer Capacitance	C <sub>rss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		15		pF	
Total Oats Observe	Qg	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 1.9 \text{ A}$		4.5	6.8	nC	
Total Gate Charge				2.3	3.5		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.9 \text{ A}$		0.8			
Gate-Drain Charge	Q <sub>gd</sub>			1			
Gate Resistance	$R_{g}$	f = 1 MHz	0.6	2.8	5.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			4	6		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 20 $\Omega$		10	15	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 1.5 A, $V_{GEN}$ = 10 V, $R_G$ = 1 $\Omega$		10	15		
Fall Time	t <sub>f</sub>			7	10.5		
Turn-On Delay Time	t <sub>d(on)</sub>			15	23		
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 20 \Omega$		16	24	ns ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = 1.5 A, $V_{GEN}$ = 4.5 V, $R_G$ = 1 $\Omega$		11	17		
Fall Time	t <sub>f</sub>			11	17		
<b>Drain-Source Body Diode Characteristic</b>	CS				L		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.39	^	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				8	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1.5 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	23	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 45 A 41/4 400 A/v- T 25 20		10	15	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 1.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12			
Reverse Recovery Rise Time	t <sub>b</sub>			3		ns	

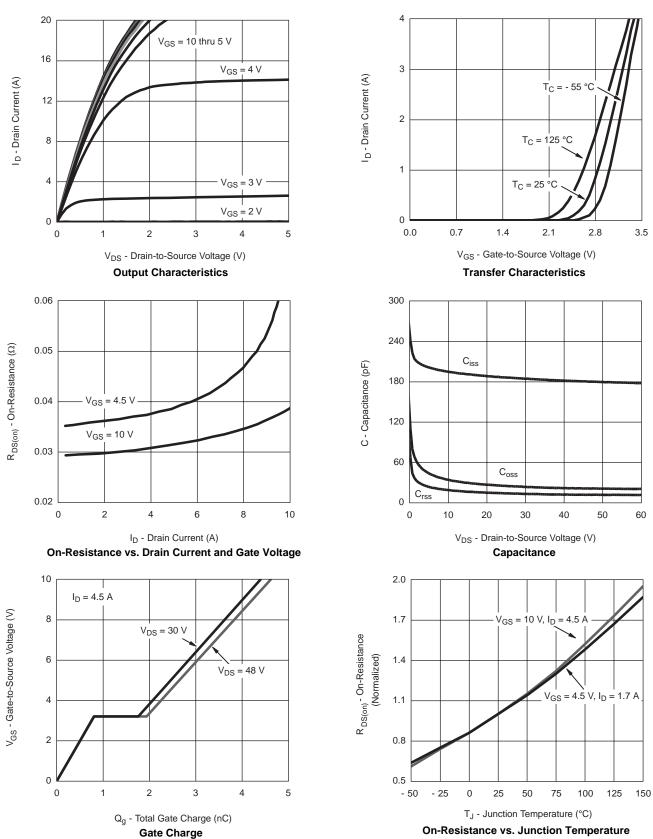
#### Notes:

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

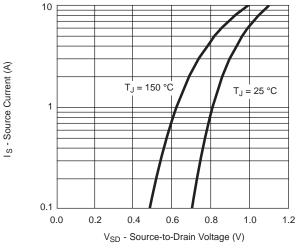


### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

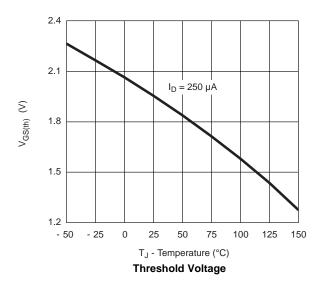


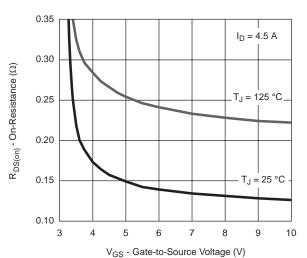


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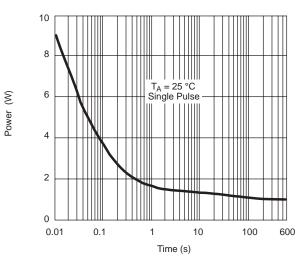


#### Source-Drain Diode Forward Voltage

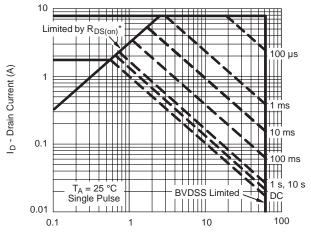




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power



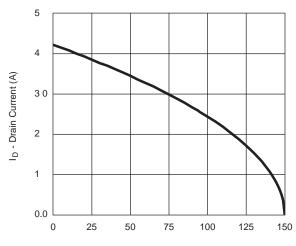
V<sub>DS</sub> - Drain-to-Source Voltage (V)

Safe Operating Area

<sup>\*</sup>  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

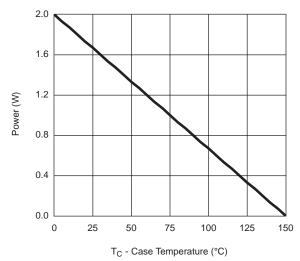


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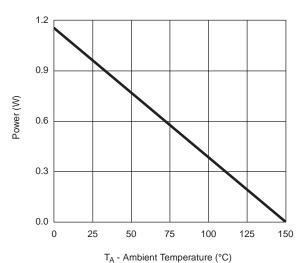


T<sub>C</sub> - Case Temperature (°C)

## Current Derating\*





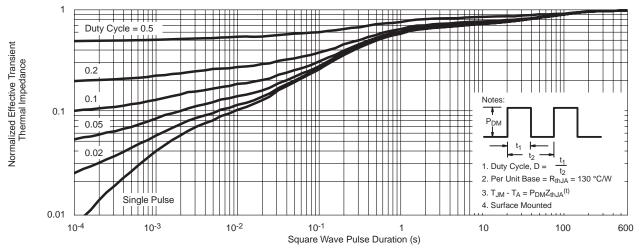


Power Derating, Junction-to-Ambient

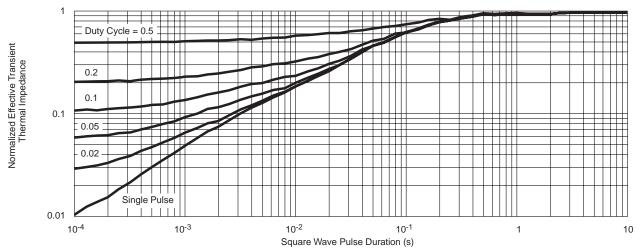
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)



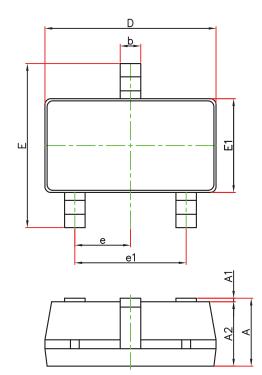


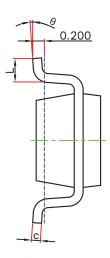


Normalized Thermal Transient Impedance, Junction-to-Foot



# **SOT-23-3L**

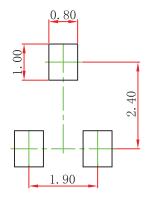




Symbol	Dimensions Ir	n Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(	(BSC)	
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



# **RECOMMENDED MINIMUM PADS FOR SOT-23-3L**



### Note:

- 1.Controlling dimension:in millimeters.
  2.General tolerance:± 0.05mm.
  3.The pad layout is for reference purposes only.

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